Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/751,705	HOSHINO, KIYO	
Examiner	Art Unit	
Dwayne J. White	3745	

	SEARCHED			
Class	Subclass	Date	Examiner	
416	5,62,207,2 09,208	5/24/65	Don	
	226;219R			
	240;132R			
	132A;70A			
	70R			
135	117,119	6/8/65	20%	
	128,24			
296	97.7,97.8			
297	184			
		<u></u>		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
		,	
		:	

SEARCH (INCLUDING SEAR		<u>')                                    </u>
	DATE	EXMR
East Search	5/24/2005	DJW
Plus Search	6/8/2005	DJW
Consulted Chris Verdier	5/24/2005	DJW
Consulted Ed Look	6/8/2005	WLO